

Notice of References Cited	Application/Control No. 10/808,081		Applicant(s)/Patent Under Reexamination WHITTTON, MATTHEW D.	
	Examiner IAN JEN		Art Unit 3664	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,241,477 A	08-1993	Narita, Yasushi	701/59
*	B	US-5,304,102 A	04-1994	Narita et al.	475/125
*	C	US-5,745,382 A	04-1998	Vilim et al.	706/16
*	D	US-5,779,594 A	07-1998	Minowa et al.	477/156
*	E	US-6,216,066 B1	04-2001	Goebel et al.	701/29
*	F	US-6,243,637 B1	06-2001	Minowa et al.	701/51
*	G	US-2001/0016539 A1	08-2001	Yuasa et al.	477/143
*	H	US-6,334,833 B1	01-2002	Ochi et al.	477/143
*	I	US-6,428,440 B2	08-2002	Yuasa et al.	475/125
*	J	US-6,503,165 B1	01-2003	Kubo et al.	475/125
*	K	US-6,961,646 B2	11-2005	Soliman et al.	701/51
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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